Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/702,551	LEE ET AL.	
Examiner	Art Unit	
Mathieu D. Vargot	1732	

	SEARCHED				
Class	Subclass	Date	Examiner		
264	1.7,1.1,				
425	808,190				
	193	7/24/05	MDV		

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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